

PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

Laboratorio de Metrología del Instituto de Ciencias Aplicadas y Tecnología - ICAT/UNAM

Circuito Exterior S/N, Ciudad Universitaria Coyoacán, Ciudad de México, México. C.P. 04510

(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

ISO/IEC 17025:2017

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

Dimensional Inspection (As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

Initial Accreditation Date:

Issue Date:

Expiration Date:

November 24, 2009

October 07, 2020

November 30, 2022

Accreditation No.:

Certificate No.:

56239

L20-594

Tracy Szerszen President

Perry Johnson Laboratory Accreditation, Inc. (PJLA) 755 W. Big Beaver, Suite 1325 Troy, Michigan 48084

The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: www.pjlabs.com





Certificate of Accreditation: Supplement

Laboratorio de Metrología del Instituto de Ciencias Aplicadas y Tecnología - ICAT/UNAM

Circuito Exterior S/N Ciudad Universitaria Coyoacán, Ciudad de México, México. C.P. 04510 Contact Name: Sergio Padilla Olvera Phone: 555-622-8602

Accreditation is granted to the facility to perform the following testing:

FIELD OF TEST	ITEMS, MATERIALS OR PRODUCTS TESTED	SPECIFIC TESTS OR PROPERTIES MEASURED	SPECIFICATION, STANDARD METHOD OR TECHNIQUE USED	RANGE (WHERE APPROPRIATE) AND DETECTION LIMIT
Dimensional	Fixtures, Parts,	Measurement of Parts	ISO 1101	CMM
Inspection ^F	Surface Finish,	Geometrically		10 mm to 650 mm
	Gages, Angle Plates	Dimensioned and		Detection Limit: 5
		Tolerance (GD&T)		Micrometers for Simple
				Touching in Aligned
				Directions to 15
				Micrometers When
				Geometric Objects are
				Related Directly with the
				Measured Parameter
			ISO 1101	Rotary Plate
				5 mm to 180 mm Diameter.
				Detection Limit: 1
				Micrometers in Radial
				Direction.
			ISO 1101	Surface Plate
				10 mm to 300 mm
				Diagonal
				Detection Limit: 3
				Micrometers.
			ISO 1101	Optical Comparator.
				1 mm to 50 mm
				Detection limit:
				3 + 40/X
				Micrometers,
				Amplification

1. The presence of a superscript F means that the laboratory performs calibration of the indicated parameter at its fixed location. Example: Outside Micrometer^F would mean that the laboratory performs this calibration at its fixed location.